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APPLICANTS

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** CONTINUING DATA *****

This application is a CON of PCT/EP02/04834 05/02/2002

PZR

** FOREIGN APPLICATIONS *****

EUROPEAN PATENT OFFICE (EPO) 01 1116 70.4 05/14/2001 ✓

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

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Foreign Priority claimed 35 USC 119 (a-d) conditions met	<input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	STATE OR COUNTRY GERMANY	SHEETS DRAWING 2 ✓	TOTAL CLAIMS 10 ✓	INDEPENDENT CLAIMS 1 ✓
Verified and Acknowledged Examiner's Signature	<i>Bon Ruzic</i>	Initials <i>RZ</i>			

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TITLE

Method for performing an alignment measurement of two patterns in different layers on a semiconductor wafer

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